

RADIO TEST REPORT

Test Report No. : 12525893H-R1

Applicant	:	DENSO CORPORATION
Type of Equipment	:	Smart Card Key
Model No.	:	14CGK
Test regulation	:	FCC Part 15 Subpart C: 2018
FCC ID	:	HYQ14CGK
Test Result	:	Complied

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- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with the above regulation.
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- 6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
- 7. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
- 8. This report is a revised version of 12525893H. 12525893H is replaced with this report.

Date of test: October 3, 2018 **Representative test** W engineer: Shuichi Ohyama Engineer Consumer Technology Division Approved by: Motoya Imura Leader Consumer Technology Division This laboratory is accredited by the NVLAP LAB CODE R 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. *As for the range of Accreditation in NVLAP, you may refer to the WEB address, http://japan.ul.com/resources/emc_accredited/ TESTING NVLAP LAB CODE: 200572-0 The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan. There is no testing item of "Non-accreditation".

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REVISION HISTORY

Original Test Report No.: 12525893H

Revision	Test report No.	Date	Page revised	Contents
-	12525893H	November 7	-	-
- (Original)	1232307311	November 7, 2018		
1	12525893H-R1	November 21	P. 15	Correction of Radiated emission data
1	1252507511-K1	November 21, 2018	1.15	Confection of Radiated emission data
		2010		

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SECTION 1: Customer information

Company Name	:	DENSO CORPORATION
Address	:	1-1 Showa-cho, Kariya-shi, Aichi-ken, 448-8661 Japan
Telephone Number	:	+81-566-20-3955
Facsimile Number	:	+81-566-25-4837
Contact Person	:	TAKAYUKI HATTORI

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	Smart Card Key
Model No.	:	14CGK
Serial No.	:	Refer to Clause 4.2
Rating	:	DC 3.0 V
Receipt Date of Sample	:	September 27, 2018
Country of Mass-production	:	Japan, United states of America and China
Condition of EUT	:	Engineering prototype
		(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab

2.2 Product Description

Model No: 14CGK (referred to as the EUT in this report) is the Smart Card Key.

Radio Type	:	Transceiver
Frequency of Operation	:	315.10 MHz / 314.35 MHz*
		*These two different frequencies are not emitted simultaneously.
Clock frequency(ies) in the system	:	18.370 MHz Crystal (RF) / 8 MHz (IC)
Modulation	:	FSK (F1D)
Type of Battery	:	One lithium battery
Antenna type	:	Built-in type (Fixed)
Receiving frequency of Operation	:	134.2 kHz *1)

*1) The test of receiver part was performed separately from this test report, and the conformability is confirmed.

* Model: 14CGK has two types; Type A and Type B. The worst case was confirmed with Type A and Type B at pre check. The test was performed with Type B, which had the worst result.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification	:	FCC Part 15 Subpart C FCC Part 15 final revised on March 12, 2018 and effective April 11, 2018
Title	:	FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators Section 15.231 Periodic operation in the band 40.66-40.70 MHz and above 70 MHz.

3.2 **Procedures and results**

Item	Test Procedure	Specification	Worst margin	Results	Remarks
	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.207		N T/A #1)	
Conducted emission	IC: RSS-Gen 8.8	IC: RSS-Gen 8.8	-N/A	N/A *1)	-
Automatically Deactivate	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(a)(1)	N/A	Complied	Radiated
	IC: -	IC: RSS-210 A1.1		1	
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(b)	9.0 dB 315.100 MHz -Vertical	Complied	Radiated
of Fundamental Emission	IC: RSS-Gen 6.12	IC: RSS-210 A1.2	PK with Duty factor		
Electric Field Strength	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.205 Section 15.209 Section 15.231(b)	8.7 dB 2835.900 MHz Vertical	Complied	Radiated
of Spurious Emission	IC: RSS-Gen 6.13	IC: RSS-210 A1.2, 4.4 RSS-Gen 8.9	PK with Duty factor <315.10 MHz>		
-20dB Bandwidth	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(c)	N/A	Complied	Radiated
	IC: -	IC: Reference data			
*1) The test is not applicab	I Work Procedures No. 13-E le since the EUT does not ha		422.	1	
Symbols: Complied Complied# The dat	The data of this test item I ta of this test item meets the	has enough margin, more th limits unless the measurem			eration.

FCC 15.31 (e)

This test was performed with the New Battery (DC 3.0 V) during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	IC: RSS-Gen 6.7	IC: RSS-210 A1.3	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor k = 2.

	Radiated emission (Below 1 GHz)						
Polarity	(3 m	*)(+/-)	(10 m*)(+/-)				
	30 MHz to 200 MHz	200 MHz to 1000 MHz	30 MHz to 200 MHz	200 MHz to 1000 MHz			
Horizontal	4.8 dB	5.2 dB	4.8 dB	5.0 dB			
Vertical	5.0 dB	6.3 dB	4.9 dB	5.0 dB			

Radiated emission (Above 1 GHz)					
(3 m*	·)(+/-)	(1 m	n*)(+/-)	(10 m*)(+/-)	
1 GHz to 6 GHz	6 GHz to 18 GHz	10 GHz to 26.5 GHz	26.5 GHz to 40 GHz	1 GHz to 18 GHz	
5.2 dB	5.5 dB	5.9 dB	5.9 dB	5.5 dB	

* Measurement distance

Automati	cally Deactivate	
0.10 %		

	Bandwidth	
0.96 %	0.96 %	

3.5 Test Location

UL Japan, Inc. Ise EMC Lab. 4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN Telephone: +81 596 24 8999, Facsimile: +81 596 24 8124 NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967

Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measuremen t distance
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.6 shielded room	-	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	-	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	-	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	-	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	-	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	-	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 m x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

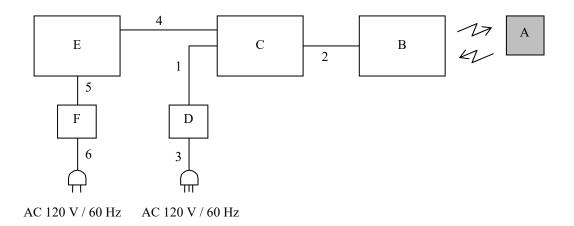
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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test Item	Mode			
Automatically Deactivate	Normal use mode, 315.10 MHz *1)			
	Normal use mode, 314.35 MHz *1)			
Electric Field Strength of Fundamental Emission	Transmitting mode (Tx), 315.10 MHz *2)			
Electric Field Strength of Spurious Emission	Transmitting mode (Tx), 314.35 MHz *2)			
-20dB & 99% Occupied Bandwidth				
* The system was configured in typical fashion (as a customer would normally use it) for testing.				
*1) The EUT transmits only when it receives 134.2 kHz radio signal. End users cannot change the settings of the				
output power of the product.				
*2) The software of this mode is the same as one of normal product, except that EUT continues to transmit when				
transmitter button is being pressed. This button was attached just for testing.(for making continuous				
transmission)				

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
Α	Smart Card Key	14CGK	002 *1)	DENSO CORPORATION	EUT
			001 *2)		
В	Door handle unit	-	-	DENSO CORPORATION	*1)
С	Test bench	-	-	DENSO CORPORATION	*1)
D	AC Adapter	-	-	DENSO CORPORATION	*1)
Е	Laptop PC	L540	R90B035F	Lenovo	*1)
F	AC Adapter	ADLX65NCC2A	11S45N0263Z1ZS9948C7	Lenovo	*1)
			3U		

*1) Used for Normal use mode only.

*2) Used for Transmitting mode only.

List of cables used

No.	Name	Length (m)	Shield		Remark
			Cable	Connector	
1	DC Cable	3.0	Unshielded	Unshielded	*1)
2	DC and Signal Cable	1.5	Unshielded	Unshielded	*1)
3	AC Cable	2.0	Unshielded	Unshielded	*1)
4	USB Cable	1.8	Shielded	Shielded	*1)
5	DC Cable	1.7	Unshielded	Unshielded	*1)
6	AC Cable	0.9	Unshielded	Unshielded	*1)

*1) Used for Normal use mode only.

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious **Emission**)

Test Procedure and conditions

[For below 30 MHz]

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

[For 30 MHz to 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

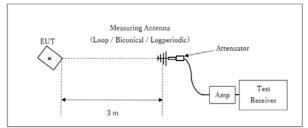
Test Antennas are used as below;

Frequency	Frequency Below 30 MHz		30 MHz to 200 MHz 200 MH		z to 1 GHz	Above 1 GHz
Antenna Type	e Loop		Biconical Logperio		odic	Horn
	From 9 kHz	From	From	From	From	Above 1 GHz
	to 90 kHz and	90 kHz	150 kHz	490 kHz	30 MHz	
	From 110 kHz	to 110 kHz	to 490 kHz	to 30 MHz	to 1 GHz	
	to 150 kHz					
Detector	Peak	Peak	Peak	Peak	Peak and	Peak and
Туре					Peak with	Peak with Duty factor
					Duty factor	
IF Bandwidth	200 Hz	200 Hz	9.1 kHz	9.1 kHz	120 kHz	PK: S/A: RBW 1 MHz,
						VBW: 3 MHz

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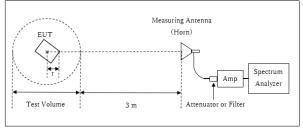
[Test Setup]

Below 1 GHz



× : Center of turn table

1 GHz - 10 GHz



r : Radius of an outer periphery of EUT

× : Center of turn table

Test Distance: 3 m

Distance Factor: $20 \text{ x} \log (3.75 \text{ m} / 3.0 \text{ m}) = 1.94 \text{ dB}$ * Test Distance: (3 + Test Volume / 2) - r = 3.75 m

Test Volume : 1.5 m (Test Volume has been calibrated based on CISPR 16-1-4.) r = 0.0 m

* The test was performed with r = 0.0 m since EUT is small and it was the rather conservative condition.

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

This EUT has two modes which mechanical key is inserted or not. The worst case was confirmed with and without mechanical key, as a result, the test without mechanical key was the worst case. Therefore the test without mechanical key was performed only.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range	: 9 kHz - 3.2 GHz
Test data	: APPENDIX
Test result	: Pass

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SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data	: APPENDIX
Test result	: Pass

SECTION 7: -20 dB and 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	150 kHz	1.5 kHz	5.1 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Peak hold was applied as Worst-case measurement.							

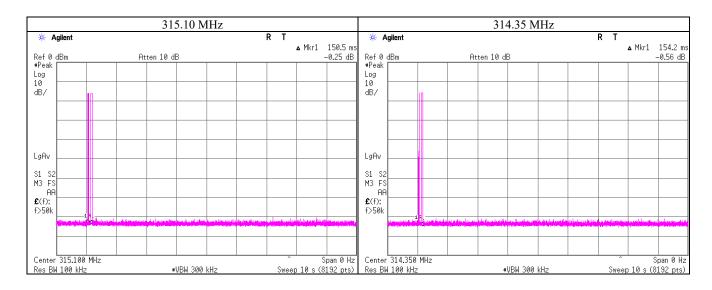
Test data	: APPENDIX
Test result	: Pass

APPENDIX 1: Test data

Automatically deactivate

Report No. Test place Date Temperature/ Humidity Engineer Mode	12525893H Ise EMC Lab. No.2 Measurement Room 10/03/2018 23 deg. C / 51 % RH Shuichi Ohyama Normal use mode
Mode	Normal use mode
Temperature/ Humidity	23 deg. C / 51 % RH

Tx Freq	Time of Transmitting [sec]	Limit [sec]	Result
315.10 MHz	0.1505	5.00	Pass
314.35 MHz	0.1542	5.00	Pass



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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No.	12525893Н
Test place	Ise EMC Lab. No.2 Semi Anechoic Chamber
Date	10/03/2018
Temperature/ Humidity	23 deg. C / 51 % RH
Engineer	Shuichi Ohyama
	(Above 1GHz)
Mode	Transmitting mode 315.10 MHz

QP or PK

Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Re	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[d	B]	Inside or Outside
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	of Restricted Bands
315.100	PK	72.1	73.0	13.9	9.0	29.3	-	65.7	66.6	95.6	29.9	29.0	Carrier
630.200	PK	36.5	34.8	19.3	10.3	29.5	-	36.6	34.9	75.6	39.0	40.7	Outside
945.300	PK	29.8	29.7	21.9	11.5	27.8	-	35.4	35.3	75.6	40.2	40.3	Outside
1260.400	PK	47.2	46.7	25.3	3.8	35.3	-	41.0	40.5	75.6	34.6	35.1	Outside
1575.500	PK	46.9	46.7	25.4	4.0	35.0	-	41.3	41.1	73.9	32.6	32.8	Inside
1890.600	PK	48.4	47.3	25.8	4.2	34.7	-	43.7	42.6	75.6	31.9	33.0	Outside
2205.700	PK	46.4	46.2	27.9	4.4	34.5	-	44.2	44.0	73.9	29.7	29.9	Inside
2520.800	PK	46.6	46.7	27.8	4.6	34.4	-	44.6	44.7	75.6	31.0	30.9	Outside
2835.900	PK	46.3	46.5	28.4	4.7	34.4	-	45.0	45.2	73.9	28.9	28.7	Inside
3151.000	PK	46.6	45.1	28.6	4.9	34.2	-	45.9	44.4	75.6	29.7	31.2	Outside

PK with Duty factor

Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Re	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[d	B]	
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	
315.100	PK	72.1	73.0	13.9	9.0	29.3	0.0	65.7	66.6	75.6	9.9	9.0	Carrier
630.200	PK	36.5	34.8	19.3	10.3	29.5	0.0	36.6	34.9	55.6	19.0	20.7	Outside
945.300	PK	29.8	29.7	21.9	11.5	27.8	0.0	35.4	35.3	55.6	20.2	20.3	Outside
1260.400	PK	47.2	46.7	25.3	3.8	35.3	0.0	41.0	40.5	55.6	14.6	15.1	Outside
1575.500	PK	46.9	46.7	25.4	4.0	35.0	0.0	41.3	41.1	53.9	12.6	12.8	Inside
1890.600	PK	48.4	47.3	25.8	4.2	34.7	0.0	43.7	42.6	55.6	11.9	13.0	Outside
2205.700	PK	46.4	46.2	27.9	4.4	34.5	0.0	44.2	44.0	53.9	9.7	9.9	Inside
2520.800	PK	46.6	46.7	27.8	4.6	34.4	0.0	44.6	44.7	55.6	11.0	10.9	Outside
2835.900	PK	46.3	46.5	28.4	4.7	34.4	0.0	45.0	45.2	53.9	8.9	8.7	Inside
3151.000	PK	46.6	45.1	28.6	4.9	34.2	0.0	45.9	44.4	55.6	9.7	11.2	Outside

Sample calculation:

Result of PK = Reading + Ant Factor + Loss (Cable + Attenuator) - Gain (Amplifier)

Result of PK with Duty factor = Reading + Ant Factor + Loss (Cable + Attenuator) - Gain (Amplifier) + Duty factor

For above 1GHz : Distance Factor: $20 \times \log (3.75 \text{ m}/3.0 \text{ m}) = 1.94 \text{ dB}$ *Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted. The result of AV (PK with Duty factor) was calculated by applying Duty 100%.

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No.	12525893Н
Test place	Ise EMC Lab. No.2 Semi Anechoic Chamber
Date	10/03/2018
Temperature/ Humidity	23 deg. C / 51 % RH
Engineer	Shuichi Ohyama
	(Above 1GHz)
Mode	Transmitting mode 314.35 MHz

QP or PK

Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Re	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[dB]		Inside or Outside
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	of Restricted Bands
314.350	PK	68.2	69.3	13.9	9.0	29.3	-	61.8	62.9	95.5	33.7	32.6	Carrier
628.700	PK	35.6	34.6	19.3	10.3	29.6	-	35.6	34.6	75.5	39.9	40.9	Outside
943.050	PK	28.5	28.6	21.8	11.5	27.8	-	34.0	34.1	75.5	41.5	41.4	Outside
1257.400	PK	47.3	46.9	25.3	3.8	35.3	-	41.1	40.7	75.5	34.4	34.8	Outside
1571.750	PK	46.4	46.5	25.5	4.0	35.0	-	40.9	41.0	73.9	33.0	32.9	Inside
1886.100	PK	49.2	48.5	25.7	4.2	34.7	-	44.4	43.7	75.5	31.1	31.8	Outside
2200.450	PK	46.2	46.5	27.9	4.4	34.5	-	44.0	44.3	73.9	29.9	29.6	Inside
2514.800	PK	46.0	46.3	27.8	4.5	34.4	-	43.9	44.2	75.5	31.6	31.3	Outside
2829.150	PK	45.9	46.2	28.4	4.7	34.4	-	44.6	44.9	73.9	29.3	29.0	Inside
3143.500	PK	46.5	46.7	28.6	4.9	34.2	-	45.8	46.0	75.5	29.7	29.5	Outside

PK with Duty factor

Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Re	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[d	B]	
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	
314.350	PK	68.2	69.3	13.9	9.0	29.3	0.0	61.8	62.9	75.5	13.7	12.6	Carrier
628.700	PK	35.6	34.6	19.3	10.3	29.6	0.0	35.6	34.6	55.5	19.9	20.9	Outside
943.050	PK	28.5	28.6	21.8	11.5	27.8	0.0	34.0	34.1	55.5	21.5	21.4	Outside
1257.400	PK	47.3	46.9	25.3	3.8	35.3	0.0	41.1	40.7	55.5	14.4	14.8	Outside
1571.750	PK	46.4	46.5	25.5	4.0	35.0	0.0	40.9	41.0	53.9	13.0	12.9	Inside
1886.100	PK	49.2	48.5	25.7	4.2	34.7	0.0	44.4	43.7	55.5	11.1	11.8	Outside
2200.450	PK	46.2	46.5	27.9	4.4	34.5	0.0	44.0	44.3	53.9	9.9	9.6	Inside
2514.800	PK	46.0	46.3	27.8	4.5	34.4	0.0	43.9	44.2	55.5	11.6	11.3	Outside
2829.150	PK	45.9	46.2	28.4	4.7	34.4	0.0	44.6	44.9	53.9	9.3	9.0	Inside
3143.500	PK	46.5	46.7	28.6	4.9	34.2	0.0	45.8	46.0	55.5	9.7	9.5	Outside

Sample calculation:

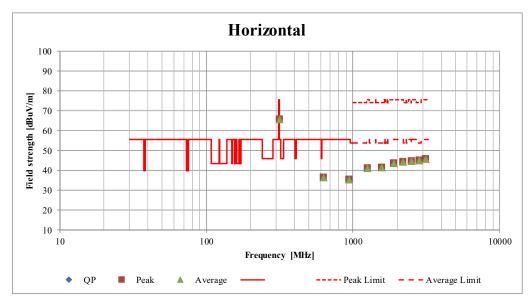
Result of PK = Reading + Ant Factor + Loss (Cable + Attenuator) - Gain (Amplifier) Result of PK with Duty factor = Reading + Ant Factor + Loss (Cable + Attenuator) - Gain (Amplifier) + Duty factor

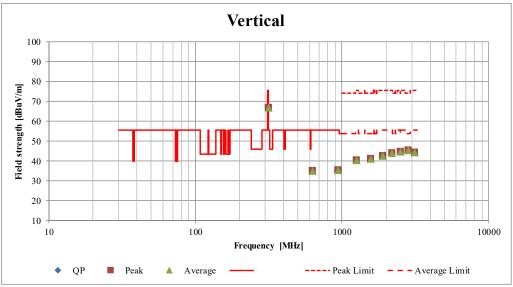
For above 1 GHz: Distance Factor: $20 \text{ x} \log (3.75 \text{ m}/3.0 \text{ m}) = 1.94 \text{ dB}$ *Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted. The result of AV (PK with Duty factor) was calculated by applying Duty 100%.

Radiated Spurious Emission (Plot data, Worst case)

Report No.12525893HTest placeIse EMC Lab. No.2 Semi Anechoic ChamberDate10/03/2018Temperature/ Humidity23 deg. C / 51 % RHEngineerShuichi Ohyama
(Above 1GHz)ModeTransmitting mode 315.10 MHz





*These plots data contains sufficient number to show the trend of characteristic features for EUT.

-20dB and 99% Occupied Bandwidth

Report No.	12525893Н
Test place	Ise EMC Lab. No.2 Measurement Room
Date	10/03/2018
Temperature/ Humidity	23 deg. C / 51 % RH
Engineer	Shuichi Ohyama
Mode	Transmitting mode 315.10 MHz / 314.35 MHz

Bandwidth Limit : Fundamental Frequency 314.35 MHz x 0.25% = 785.88 kHz

* The above limit was calculated from more stringent nominal frequency.

* Method of KDB 926416 for systems employing non sweeping frequencies was referred.

315.10 MHz

-20dB Bandwidth
[kHz]
37.02

314.35 MHz
-20dB Bandwidth
[kHz]
36.95

-20dB Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
37.02 + 36.95 = 73.97	785.88	Pass

Bandwidth Limit : Fundamental Frequency 315.10 MHz x 0.25% = 787.75 kHz

99% Occupied Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
36.5091	787.75	Pass

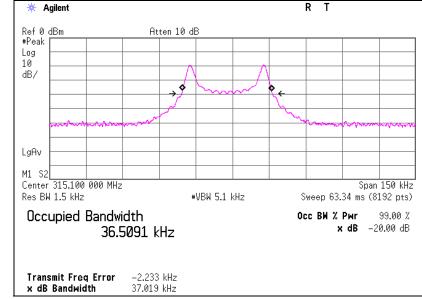
Bandwidth Limit : Fundamental Frequency 314.35 MHz x 0.25% = 785.88 kHz

99% Occupied Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
36.5620	785.88	Pass

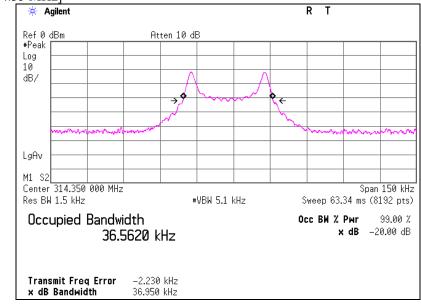
-20dB and 99% Occupied Bandwidth

Report No.	12525893Н
Test place	Ise EMC Lab. No.2 Measurement Room
Date	10/03/2018
Temperature/ Humidity	23 deg. C / 51 % RH
Engineer	Shuichi Ohyama
Mode	Transmitting mode 315.10 MHz / 314.35 MHz









Test report No.	: 12525893H-R1
Page	: 19 of 22
Issued date	: November 21, 2018
FCC ID	: HYQ14CGK

Test e	quipmen	t						
Test item	LÍMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
RE	141203	Attenuator(6dB)	Weinschel Corp	2	BK7970	11/14/2017	11/30/2018	12
RE	142006	AC2_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-06902	4/2/2018	4/29/2019	12
RE	141317	Coaxial Cable	Fujikura/Agilent	-	-	2/23/2018	2/28/2019	12
RE	141542	Digital Tester	Fluke Corporation	FLUKE 26-3	78030611	8/21/2018	8/31/2019	12
RE	141152	EMI measurement program	TSJ	TEPTO-DV	-	-	-	-
RE	141265	Logperiodic Antenna(200- 1000MHz)	Schwarzbeck	VUSLP9111B	911B-190	5/31/2018	5/31/2019	12
RE	142228	Measure	KOMELON	KMC-36	-	-	-	-
RE	141578	Pre Amplifier	AGILENT	8447D	2944A10845	9/19/2018	9/30/2019	12
RE	141556	Thermo-Hygrometer	CUSTOM	CTH-201	0003	12/21/2017	12/31/2018	12
RE	141512	Horn Antenna 1- 18GHz	Schwarzbeck	BBHA9120D	254	6/6/2018	6/30/2019	12
RE	141392	Microwave Cable	Junkosha	MWX221	1604S253(1 m) / 1608S087(5 m)	8/8/2018	8/31/2019	12
RE	141579	Pre Amplifier	AGILENT	8449B	3008A02142	1/23/2018	1/31/2019	12
RE	141885	Spectrum Analyzer	AGILENT	E4448A	US44300523	11/14/2017	11/30/2018	12
RE	142004	AC2_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	6/29/2018	6/30/2020	24
RE	141942	Test Receiver	Rohde & Schwarz	ESCI	100300	8/8/2018	8/31/2019	12
RE	141427	Biconical Antenna	Schwarzbeck	VHA9103B	8031	5/31/2018	5/31/2019	12
RE	142645	Loop Antenna	UL Japan	-	-	-	-	-

APPENDIX 2: Test Instruments

*Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item:

RE: Radiated emission, 99 % Occupied Bandwidth, -20 dB bandwidth and Automatically deactivate tests